

20V Dual N-Channel MOSFET

General Description

The AO4806 uses advanced trench technology to provide excellent R_{DS(ON)} and low gate charge. They offer operation over a wide gate drive range from 1.8V to 12V. It is ESD protected. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration.

Product Summary

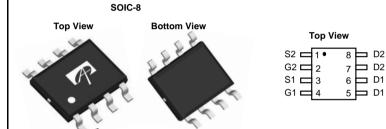
$$\begin{split} &V_{DS}\left(V\right) = 20V \\ &I_{D} = 9.4A \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 14m\Omega \; (V_{GS} = 10V) \end{split}$$

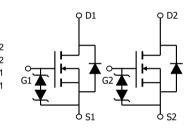
 $R_{DS(ON)} < 14 ms^2 (V_{GS} = 16V)$ $R_{DS(ON)} < 15 m\Omega (V_{GS} = 4.5V)$ $R_{DS(ON)} < 21 m\Omega (V_{GS} = 2.5V)$ $R_{DS(ON)} < 30 m\Omega (V_{GS} = 1.8V)$

ESD Rating: 2000V HBM 100% UIS Tested

100% Rg Tested







Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	20	V				
Gate-Source Voltage		V_{GS}	±12	V				
Continuous Drain	T _A =25°C		9.4					
Current ^A	T _A =70°C	I _D	7.5	Α				
Pulsed Drain Current ^B		I _{DM}	40					
	T _A =25°C	D	2	W				
Power Dissipation	T _A =70°C	$-P_{D}$	1.28	VV				
Junction and Storage Temperature Range		T_J , T_{STG}	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{ heta JA}$	45	62.5	°C/W			
Maximum Junction-to-Ambient A	Steady-State	IN _θ JA	72	110	°C/W			
Maximum Junction-to-Lead ^C Steady-State		$R_{ hetaJL}$	34	40	°C/W			



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$	20			V
I _{DSS} Zero Gate Voltage Dra	Zoro Cato Voltago Drain Current	V _{DS} =16V, V _{GS} =0V			10	μА
	Zero Gale voltage Drain Current	T _J =55°C			25	
I _{GSS}	Gate-Source leakage current	V_{DS} =0V, V_{GS} =±10V			±10	μΑ
BV_{GSO}	Gate-Source Breakdown Voltage	V_{DS} =0V, I_{G} =±250uA	±12			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	0.5	0.75	1	V
I _{D(ON)}	On state drain current	V_{GS} =4.5V, V_{DS} =5V	30			Α
		V_{GS} =10V, I_D =9.4A		11	14	m()
		T _J =125°C		14.3	17	mΩ
	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =8A		12.6	16	mΩ
		V _{GS} =2.5V, I _D =6A		16.5	22	mΩ
		V _{GS} =1.8V, I _D =4A		23.4	30	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =9.4A		37		S
V_{SD}	Diode Forward Voltage	I _S =1A		0.72	1	V
Is					3	Α
DYNAMIC	PARAMETERS					
C _{iss}	Input Capacitance			1810		pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz		232		pF
C _{rss}	Reverse Transfer Capacitance	1		200		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.6		Ω
SWITCHI	NG PARAMETERS					
Q_g	Total Gate Charge			17.9		nC
Q_{gs}	Gate Source Charge	V _{GS} =4.5V, V _{DS} =10V, I _D =9.4A		1.5		nC
Q_{gd}	Gate Drain Charge	1		4.7		nC
t _{D(on)}	Turn-On DelayTime			3.3		ns
t _r	Turn-On Rise Time	$V_{GS}=10V, V_{DS}=10V, R_{L}=1.1\Omega,$		5.9		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		44		ns
t _f	Turn-Off Fall Time	1		7.7		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =9.4A, dI/dt=100A/μs		22		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =9.4A, dI/dt=100A/μs		8.6		nC

A: The value of R $_{0JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any a given application depends on the user's specific board design. The current rating is based on the t 🛛 🗧 10s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

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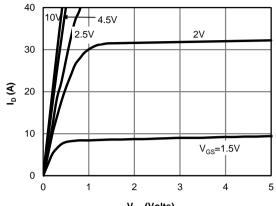
C. The R _{0JA} is the sum of the thermal impedence from junction to lead R _{0JL} and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 µs pulses, duty cycle 0.5% max.

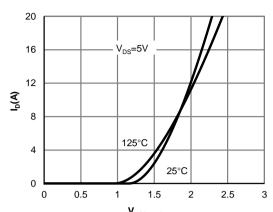
E. These tests are performed with the device mounted on 1 in ² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The SOA curve provides a single pulse rating.



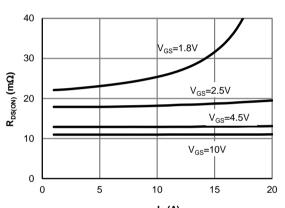
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



V_{DS} (Volts) Fig 1: On-Region Characteristics



 $V_{\rm GS(Volts)}$ Figure 2: Transfer Characteristics



 $\label{eq:ldots} {\rm I_D}\left({\rm A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage

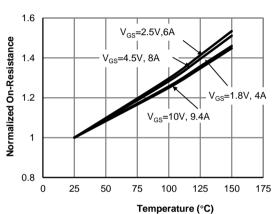
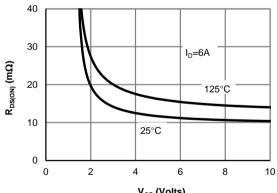
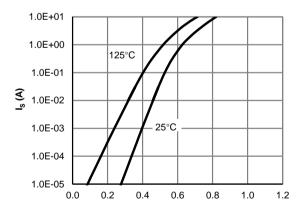


Figure 4: On-Resistance vs. Junction Temperature



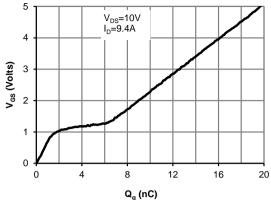
V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage

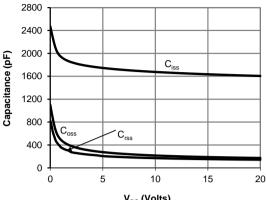


V_{SD} (Volts)
Figure 6: Body-Diode Characteristics

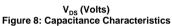


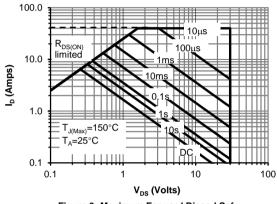
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 ${\bf Q_g}$ (nC) Figure 7: Gate-Charge Characteristics





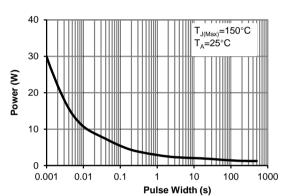


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

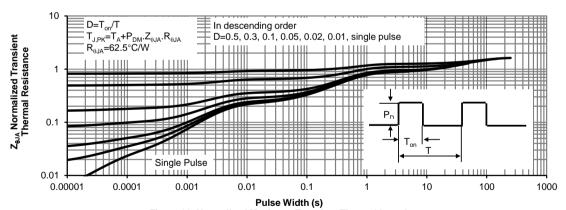


Figure 11: Normalized Maximum Transient Thermal Impedance